

Replaces DS5616-3

DIM400GDM33-F000

Dual Switch IGBT Module

DS5616-4 January 2018 (LN35023)

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM400GDM33-F000 is a single switch 3300V, nchannel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

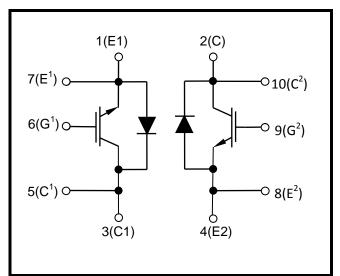
DIM400GDM33-F000

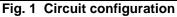
Note: When ordering, please use the complete part number

KEY PARAMETERS

V _{CES}		3300V
V _{CE(sat)}	* (typ)	2.8V
lc	(max)	400A
I _{C(PK)}	(max)	800A

* Measured at the auxiliary terminals







ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V$	3300	V
V _{GES}	Gate-emitter voltage		±20	V
I _C	Continuous collector current	$T_{case} = 90^{\circ}C$	400	А
I _{C(PK)}	Peak collector current	1ms, $T_{case} = 115^{\circ}C$	800	А
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	5.2	kW
l ² t	Diode I ² t value	$V_R = 0, t_p = 10ms, T_j = 125^{\circ}C$	80	kA ² s
V _{isol} *	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Q _{PD}	Partial discharge – per module	IEC1287, $V_1 = 3500V$, $V_2 = 2600V$, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AISiC
Creepage distance:	33mm
Clearance:	20mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	24	°C/kW
R _{th(j-c)}	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	48	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	8	°C/kW
Tj	Junction temperature	Transistor	-	-	125	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
	0	$V_{GE} = 0V, V_{CE} = V_{CES}$			2	mA
I _{CES}	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			30	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μA
V _{GE(TH)}	Gate threshold voltage	$I_{C} = 40 \text{mA}, V_{GE} = V_{CE}$	5.5	6.5	7.0	V
v t	Collector-emitter	V _{GE} = 15V, I _C = 400A		2.8		V
V _{CE(sat)} †	saturation voltage	V _{GE} = 15V, I _C = 400A, T _j = 125°C		3.6		V
I _F	Diode forward current	DC		400		Α
I _{FM}	Diode maximum forward current	t _p = 1ms		800		А
t		I _F = 400A		2.9		V
V _F [†] Diode forward voltage		I _F = 400A, T _j = 125°C		3.0		V
C _{ies}	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		72		nF
Qg	Gate charge	±15V		10		μC
C _{res}	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		1.1		nF
L _M	Module inductance			25		nH
R _{INT}	Internal transistor resistance			260		μΩ
SC _{Data}	Short circuit current, I _{SC}	$\begin{split} T_{j} &= 125^{\circ}C, \ V_{CC} = 2500V \\ t_{p} &\leq 10 \mu s, \ V_{GE} \leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dl/dt \\ IEC \ 60747-9 \end{split}$		1850		A

Note:

 $\ensuremath{^+}$ Measured at the power busbars, not the auxiliary terminals $\ensuremath{^*}$ L is the circuit inductance + L_M

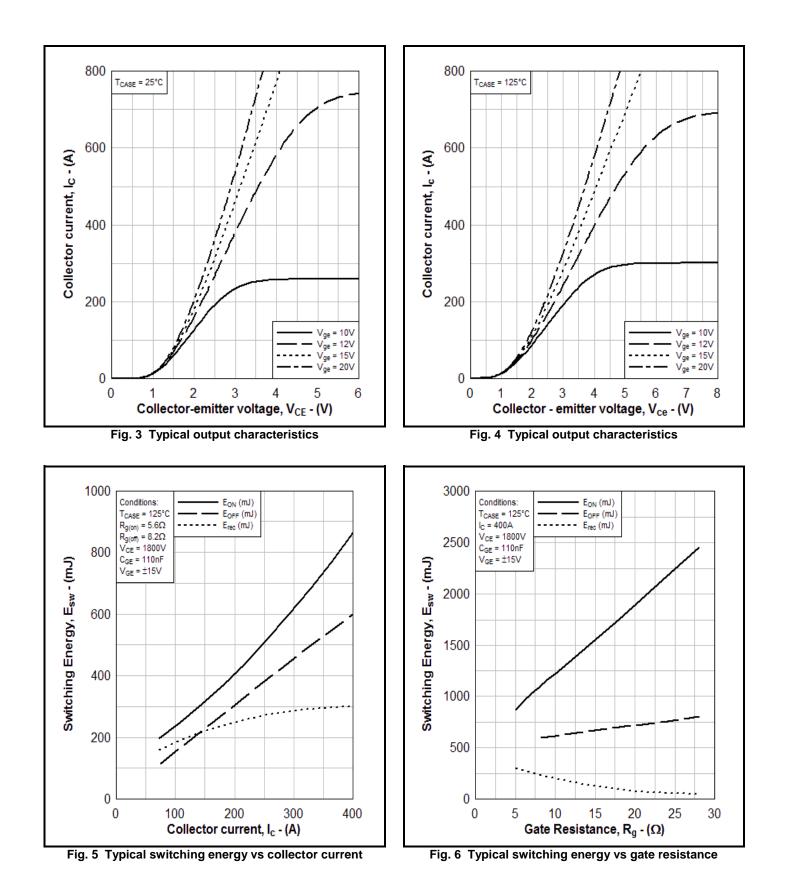
ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 400A		2100		ns
t _f	Fall time	$V_{GE} = \pm 15V$		210		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 1800V$		520		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 5.6\Omega$ $R_{G(OFF)} = 8.2\Omega$		1130		ns
t _r	Rise time	$C_{ge} = 110 nF$		245		ns
E _{ON}	Turn-on energy loss	L _s ~ 100nH		620		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 400A		160		μC
l _{rr}	Diode reverse recovery current	V _{CE} = 1800V		330		А
E _{rec}	Diode reverse recovery energy	dI _F /dt = 2000A/µs		150		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t _{d(off)}	Turn-off delay time	I _C = 400A		2150		ns
t _f	Fall time	$V_{GE} = \pm 15V$		220		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 1800V$		600		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 5.6\Omega$ $R_{G(OFF)} = 8.2\Omega$		1160		ns
t _r	Rise time	$C_{ge} = 110 nF$		285		ns
E _{ON}	Turn-on energy loss	L _s ~ 100nH		870		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 400A		300		μC
I _{rr}	Diode reverse recovery current	$V_{CE} = 1800V$		400		А
E_{rec}	Diode reverse recovery energy	dI _F /dt = 2000A/µs		300		mJ



Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures

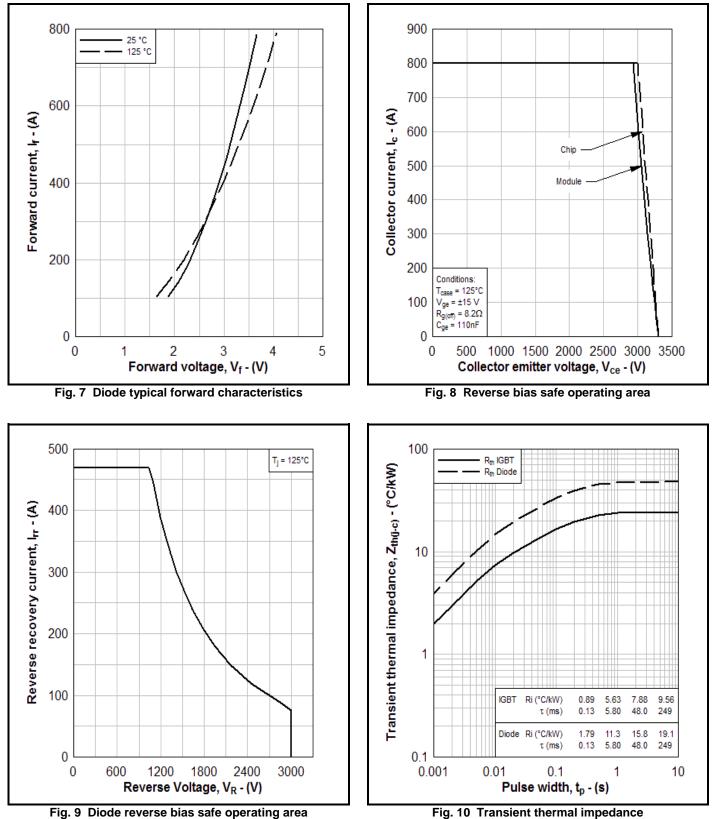
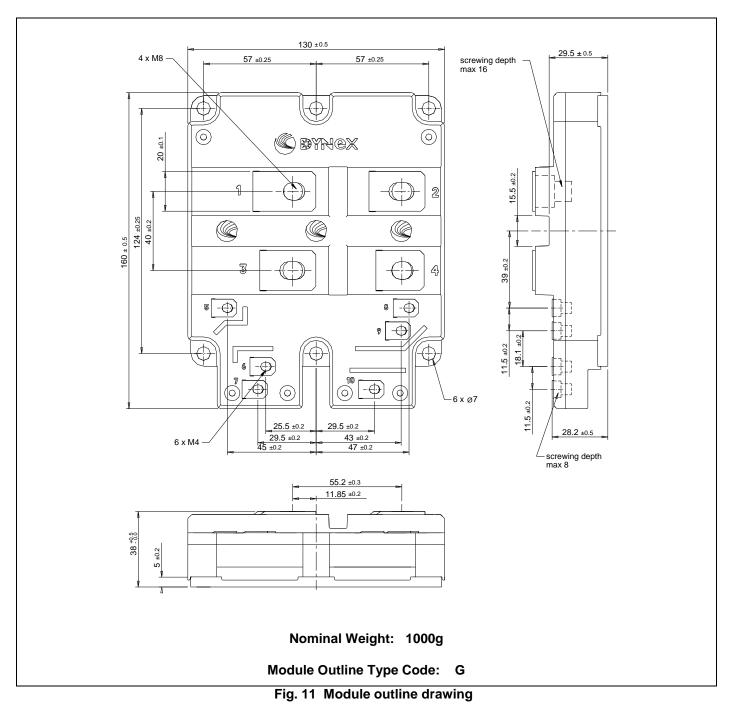


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.**



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The products must not be touched when operating because there is a danger of electrocution or severe burning. Always use protective safety equipment such as appropriate shields for the product and wear safety glasses. Even when disconnected any electric charge remaining in the product must be discharged and allowed to cool before safe handling using protective gloves.

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